


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539109	<b>Applicant(s)/Patent Under Reexamination</b>  YOSHINO ET AL.
	<b>Examiner</b>  Quang T Van	<b>Art Unit</b>  3742

SEARCHED			
Class	Subclass	Date	Examiner
219	756,750,710,748,749,754,746,751,681	7/19/06	QV
43	45	7/19/06	QV
	Update seaech	7/11/2008	QV
	Updated search	12/29/2008	QV

SEARCH NOTES			
Search Notes		Date	Examiner
East search		7/19/06	QV
Inventor check		7/19/06	QV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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